

SEARCHED

Class	Sub.	Date	Exmr.
435 ↓ 516	198 252.3 320.1 28-2	4.2.03 ↓	80 ↓

INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
<ul style="list-style-type: none"> • STIC scan Seq W no: 1-2 [in kit] • Inverter scan No kit • [photolips] [Cc] Churn 	4.2.03 ↓	87 ↓